

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSVI)

# **TPC8004**

Lithium Ion Battery Applications
Portable Equipment Applications
Notebook PC Applications

• Small footprint due to small and thin package

• Low drain-source ON resistance :  $RDS(ON) = 37 \text{ m}\Omega \text{ (typ.)}$ 

• High forward transfer admittance :  $|Y_{fs}| = 6 S \text{ (typ.)}$ 

• Low leakage current :  $I_{DSS} = 10 \mu A \text{ (max) (V}_{DS} = 30 \text{ V)}$ 

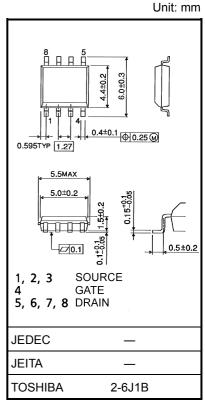
• Enhancement-mode :  $V_{th} = 0.8 \sim 2.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$ 

#### **Maximum Ratings (Ta = 25°C)**

Characte	ristics	Symbol	Rating	Unit	
Drain-source voltage		V <sub>DSS</sub>	30	V	
Drain-gate voltage (F	R <sub>GS</sub> = 20 kΩ)	$V_{DGR}$	30	V	
Gate-source voltage		V <sub>GSS</sub>	±20	V	
Drain current	DC (Note 1)	I <sub>D</sub>	5	А	
Diain current	Pulse (Note 1)	I <sub>DP</sub>	20	A	
Drain power dissipati	on (t = 10 s) (Note 2a)	$P_{D}$	2.4	W	
Drain power dissipati	on (t = 10 s) (Note 2b)	P <sub>D</sub>	1.0	W	
Single pulse avalance	he energy (Note 3)	E <sub>AS</sub>	32.5	mJ	
Avalanche current		I <sub>AR</sub>	5	Α	
Repetitive avalanche (	energy Note 2a) (Note 4)	E <sub>AR</sub>	0.24	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature	range	T <sub>stg</sub>	-55 to 150	°C	

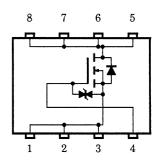
Note: For (Note 1), (Note 2), (Note 3) and (Note 4), please refer to the next page.

This transistor is an electrostatic sensitive device. Please handle with caution.



Weight: 0.080 g (typ.)

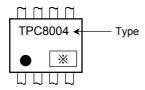
### **Circuit Configuration**



#### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	R <sub>th (ch-a)</sub>	52.1	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2b)	R <sub>th (ch-a)</sub>	125	°C/W

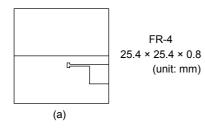
#### Marking (Note 5)

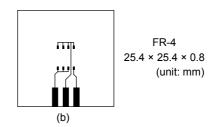


Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2: (a) Device mounted on a glass-epoxy board (a)

(b) Device mounted on a glass-epoxy board (b)





Note 3:  $V_{DD}$  = 24 V,  $T_{ch}$  = 25°C (initial), L = 1.0 mH,  $R_G$  = 25  $\Omega$ ,  $I_{AR}$  = 5 A

Note 4: Reptitve rating; pulse width limited by maximum channel temperature

Note 5: ● on lower left of the marking indicates Pin 1.

\* shows lot number. (year of manufacture: last decimal digit of the year of manufacture, month of manufacture: January to December are denoted by letters A to L respectively.)



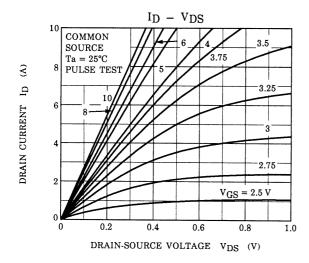
## Electrical Characteristics (Ta = 25°C)

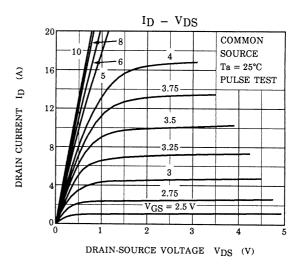
Chara	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage c	urrent	I <sub>GSS</sub>	V <sub>GS</sub> = ±16 V, V <sub>DS</sub> = 0 V	_	_	±10	μA
Drain cut-off cu	ırrent	I <sub>DSS</sub>	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V	10		μA	
Drain-source b	reakdown voltage	V <sub>(BR) DSS</sub>	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	30	_	_	V
Gate threshold	voltage	V <sub>th</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	8.0	_	2.0	V
Drain-source ON resistance		R <sub>DS (ON)</sub>	V <sub>GS</sub> = 4 V, I <sub>D</sub> = 2.5 A	_	58	80	mΩ
			V <sub>GS</sub> = 10 V, I <sub>D</sub> = 2.5 A	_	37	50	
Forward transfe	er admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 2.5 A	3	6	_	S
Input capacitan	ce	C <sub>iss</sub>		_	475	_	
Reverse transfer capacitance		C <sub>rss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz	-	85	_	pF
Output capacita	Output capacitance			_	270	_	
Switching time	Rise time	tr	$V_{GS} = 2.5 \text{ A}$ $V_{GS} = 0 \text{ V}$ $V_{DD} = 15 \text{ V}$ $V_{DD} = 15 \text{ V}$ $V_{DU} = 10  \mu\text{s}$	_	10	_	
	Turn-on time	t <sub>on</sub>		_	16	_	
	Fall time	t <sub>f</sub>		_	13	_	ns ns
	Turn-off time	t <sub>off</sub>		_	70	_	
Total gate charge (Gate-source plus gate-drain)		Qg		_	16	_	nC
Gate-source charge		Q <sub>gs</sub>	$V_{DD} \approx 24 \text{ V, } V_{GS} = 10 \text{ V, } I_D = 5 \text{ A}$	_	11		
Gate-drain ("mi	Gate-drain ("miller") charge			_	5	_	

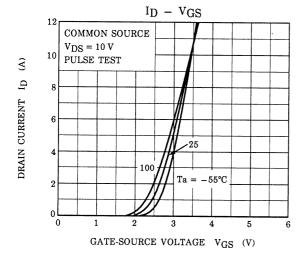
# Source-Drain Ratings and Characteristics (Ta = 25°C)

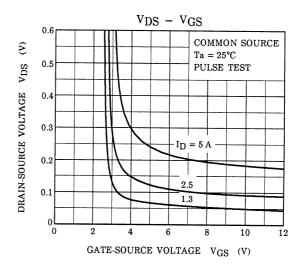
Charact	eristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I <sub>DRP</sub>	_	_	_	20	А
Forward voltage (diode) $V_{DSF}$ $I_{DR} =$		$I_{DR}$ = 5 A, $V_{GS}$ = 0 V	-	_	-1.2	V	

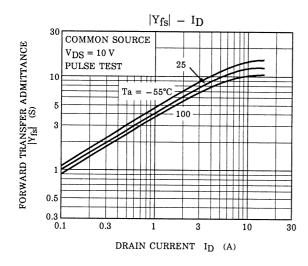
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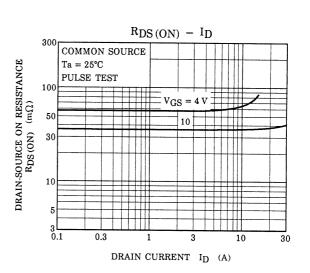




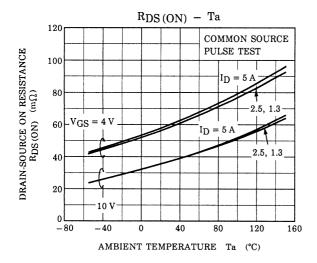


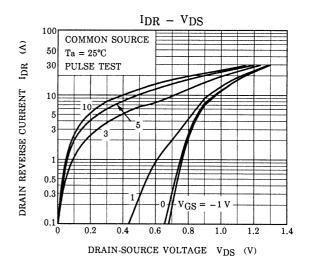


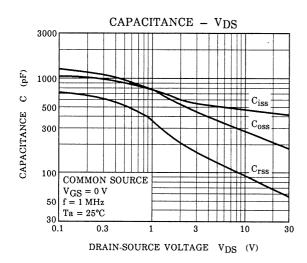


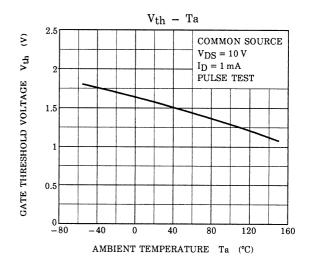


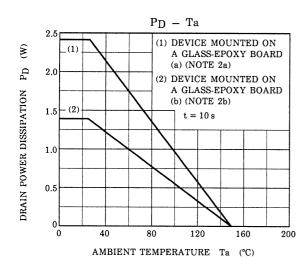
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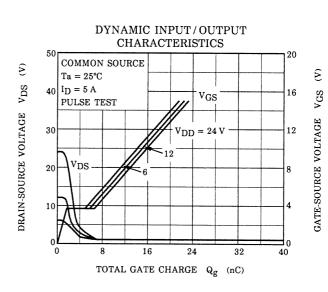


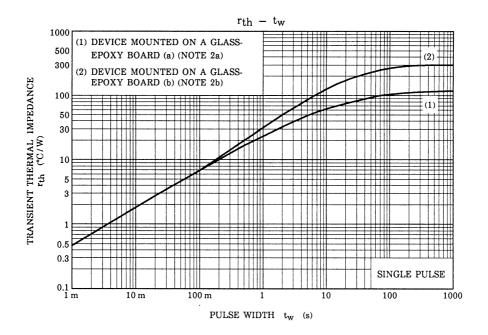


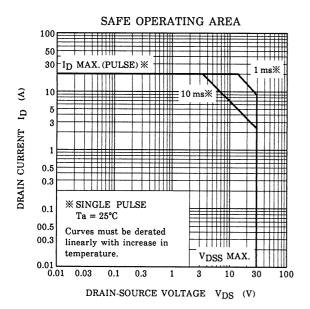


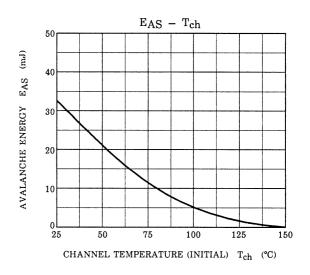


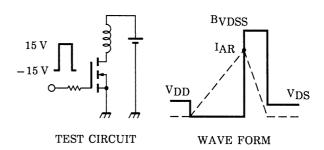












$$\begin{array}{l} T_{ch} = 25^{\circ}\text{C (Initial)} \\ \text{Peak IAR} = 5\,\text{A, R}_{G} = 25\,\Omega \end{array} \quad E_{AS} = \frac{1}{2} \cdot \text{L} \cdot \text{I}^{2} \cdot \ (\frac{\text{BVDSS}}{\text{BVDSS} - \text{VDD}}) \\ \text{V}_{DD} = 24\,\text{V, L} = 1.0\,\text{mH} \end{array}$$

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